

PMA-12

Photonic multichannel analyzer



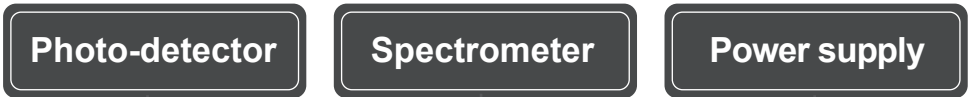
Scientific applications

- UV to visible spectroscopy
- Gas chromatography
- Fluorescence spectroscopy
- Raman scattering
- Luminous efficiency measurement
- Discharge spectrum analysis
- Chemiluminescence analysis
- Combustion analysis
- Liquid chromatography
- Micro spectroscopy

Industrial applications

- Water quality testing
- UV radiation measurements
- Evaluation of light emitting devices and light sources
- Plasma monitoring
- Photobiological safety assessment
- Chromaticity measurements
- Combustion monitoring
- Impurities testing
- Color filter evaluation
- Film thickness measurements

PRODUCT INTRODUCTION



Use of an optical fiber input makes spectral measurements easy.

The PMA-12 is a compact spectral measurement system that combines a spectrometer and optical detector into one unit. Because of the high sensitivity, spectra can easily be obtained in many applications, just by bringing the optical fiber close to the sample without the connection to a special light collection system. Since the spectrometer and photo-detector are manufactured with high machine accuracy, the PMA-12 is stable and can be used with confidence for long periods of time. The wavelength axis and spectral response characteristics are already calibrated, so spectral measurements can be carried out easily and accurately.



▲C14880-01

C14880-01 Low stray light model

This model realizes low stray light and enables highly accurate spectrum analysis by reviewing the optical layout. By using a sensor with a built-in cooling element, low noise and highly reproducible measurements have been achieved.

C14631-01, -02, -03 High sensitivity superior cost-performance model

The most compact high-performance model in the PMA-12 series. Highly accurate spectrum analysis from basics to applications can be realized at a low price. The wavelength range for measurements is 300 nm to 800 nm for the C14631-01 and 250 nm to 840 nm for the C14631-02 and 300 nm to 1040 nm for the C14631-03.

C10028-01, -02 Near infrared model

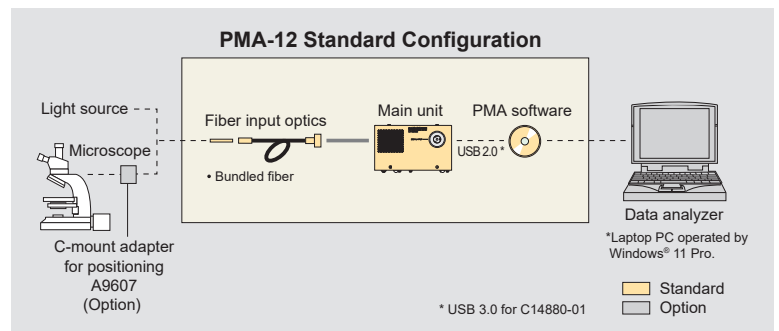
These are models using InGaAs linear image sensors which are capable of measuring reflection and absorption spectra in the near infrared with a large dynamic range. The wavelength range for measurements is 900 nm to 1650 nm for the C10028-01 and 1600 nm to 2350 nm for the C10028-02.

C10027-01, -02 Ultra-high sensitivity model

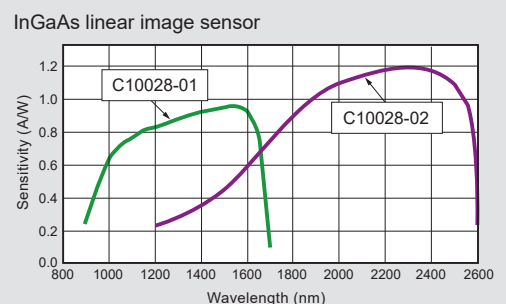
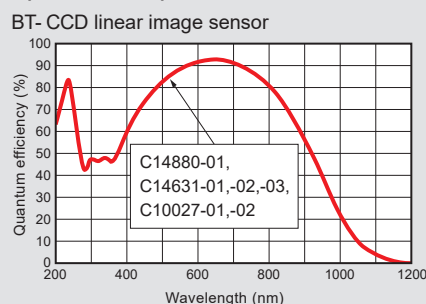
The ultra-sensitive model that can measure a wide wavelength range from ultraviolet to near-infrared with high wavelength resolution by using a specially designed spectrometer, spectral measurement over a wide wavelength range is possible with high wavelength resolution. The wavelength range for measurements is 200 nm to 950 nm for the C10027-01 and 350 nm to 1100 nm for the C10027-02.

Features

- Spectrometer, photo-detector and power supply in a compact unit
- Real-time measurements (Simultaneous measurement of multiple wavelengths possible)
- Easy measurements with optical fiber
- Spectral response and wavelength calibrated
- Support many applications with the option

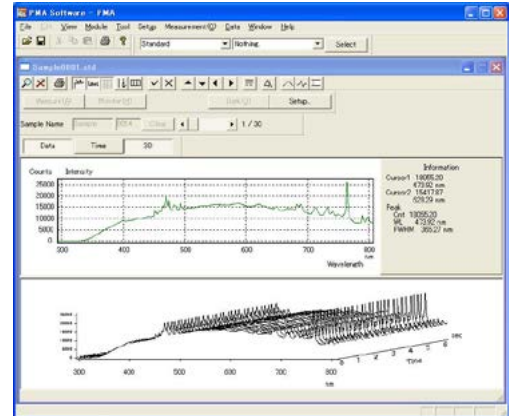


● Spectral response (Typ.)



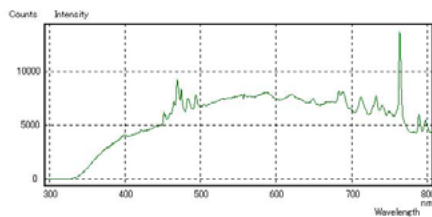
Measurement modes

- Standard measurements**
 This is the most basic measurement mode.
 Applications: e.g. emission spectra for light sources, fluorescence, plasma and etc.
- Reflective measurements**
 This is the measurement mode for finding spectral reflectance.
 Applications: e.g. reflectance measurements for optical filters, coatings and etc.
- Transmittance and absorption measurements**
 This is the measurement mode for finding spectral transmittance and absorption.
 Applications: e.g. measurements of transmittance and absorption in optical filters, films, solutions and etc.
- Chromaticity measurements (light-source color)**
 This is the measurement mode for finding the light-source color for luminous bodies.
 Applications: e.g. color evaluation in light sources for illumination, LEDs and etc.
- Chromaticity measurements (object color)**
 This is the mode for finding the color of objects that are either reflective or transmit light.
 Applications: e.g. color evaluation of paint, fabric, printed matter and etc.

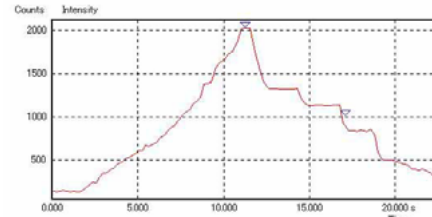


Display modes

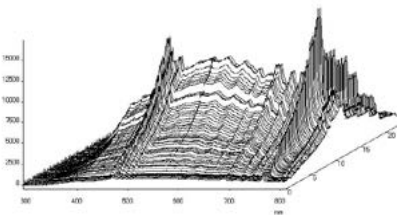
Spectrum display



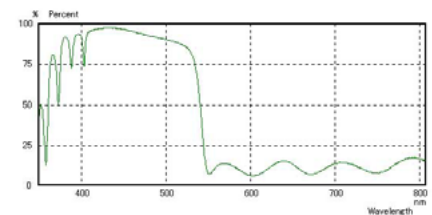
Display of changes over time



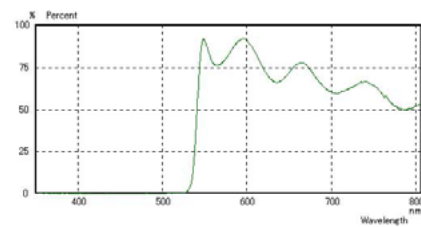
3-D display



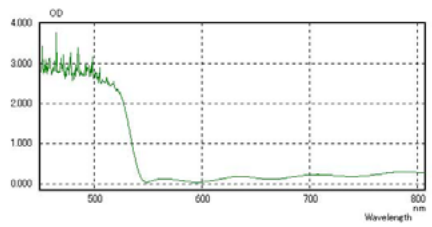
Reflectivity display



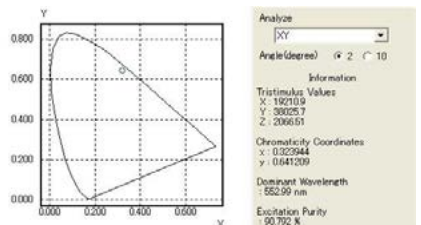
Transmittance display



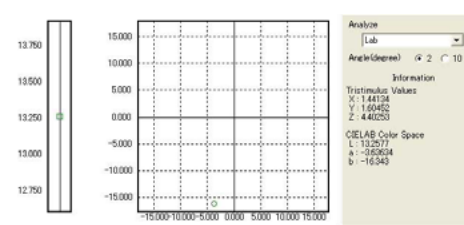
Absorbance display (OD)



Color coordinate display



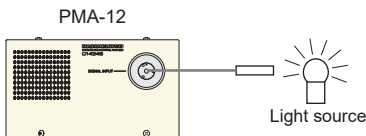
Spatial color coordinate display



APPLICATION EXAMPLES

Light source measurements

Measurement of emission spectra in light sources such as lamps and LEDs



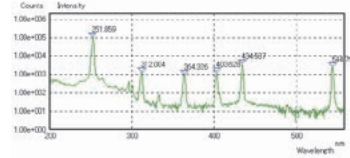
< Configuration >

- Standard PMA-12 configuration (C14880, C14631, C10027, etc.)

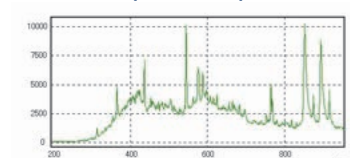
< Applications >

- Evaluation of color temperature and color rendering properties in light sources for illumination
- LED chromaticity evaluations
- Special applications of light source spectral evaluations

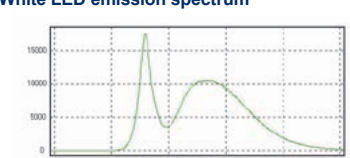
Germicidal lamp emission spectrum



Metal halide lamp emission spectrum

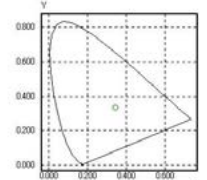


White LED emission spectrum

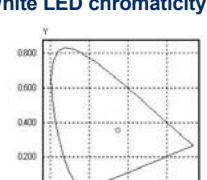


■ Analysis of light source color by emission spectrum (chromaticity, color temperature, color rendering properties, etc.)

Metal halide lamp chromaticity evaluation

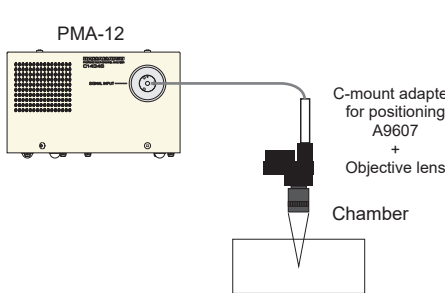


White LED chromaticity evaluations



Emission spectrum measurements

Emission spectrum measurements for plasma, electric discharge, ablation and the like



< Configuration >

- Standard PMA-12 configuration (C14880, C14631, C10027, etc.)

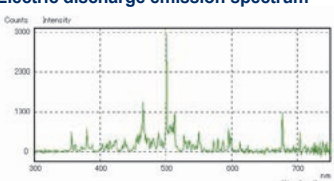
Options

- C-mount adapter for positioning A9607

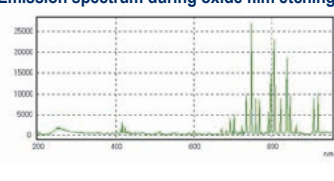
< Applications >

- Plasma component analysis
- Analysis of various emission phenomena

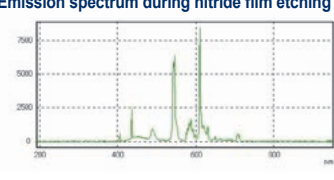
Electric discharge emission spectrum



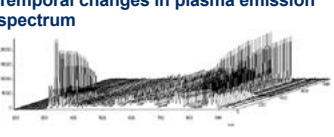
Emission spectrum during oxide film etching



Emission spectrum during nitride film etching

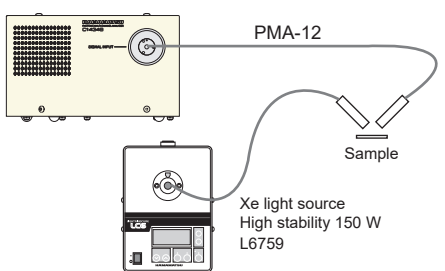


Temporal changes in plasma emission spectrum



Reflective spectrum measurements

Measurement of spectral reflectance in optical filters, anti-reflective films (AR coatings) and the like



< Configuration >

- Standard PMA-12 configuration (C14880, C14631, C10027, etc.)

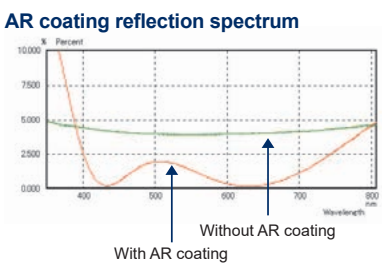
Options

- Xe light source high stability 150 W L6759
- Optical split fiber UV to VIS 2 m A10193-01

< Applications >

- Inspection of coatings
- Monitoring thin film growth

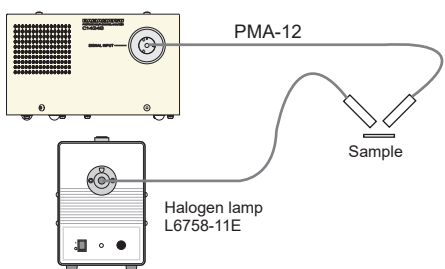
AR coating reflection spectrum



APPLICATION EXAMPLES

Object color measurements

Object color measurement of paint, fabric, printed matter and the like



PMA-12

Halogen lamp L6758-11E

Sample

< Configuration >

- Standard PMA-12 configuration (C14880, C14631, C10027, etc.)

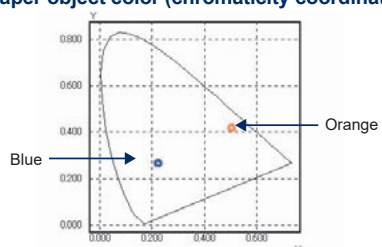
Option

- Halogen lamp L6758-11E

< Applications >

- Paint inspections
- Color evaluations in printed matter, fabric, plastics, etc.

Paper object color (chromaticity coordinates)

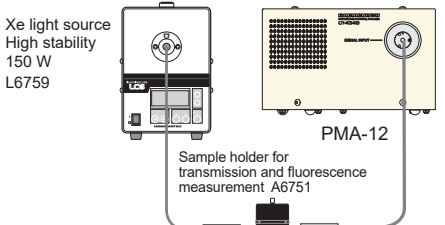


Blue

Orange

Absorption spectrum measurements

Spectral transmittance and absorption measurements in optical filters, films, solutions and the like

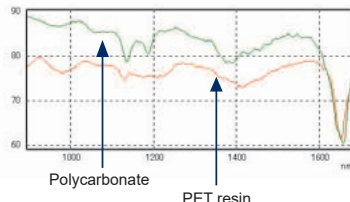


Xe light source
High stability
150 W
L6759

PMA-12

Sample holder for transmission and fluorescence measurement A6751

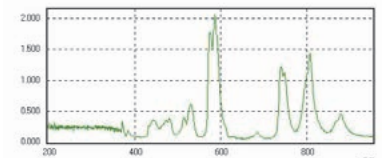
Component analysis of plastics using transmission spectra (polycarbonate and PET resins)



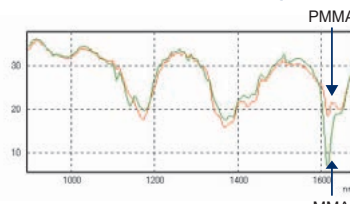
Polycarbonate

PET resin

Didymium film absorption spectrum



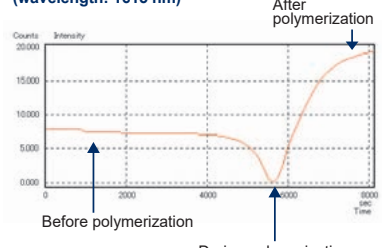
MMA and PMMA transmission spectra



PMMA

MMA

Changes of transmission in the polymerization from MMA to PMMA (wavelength: 1615 nm)



After polymerization

Before polymerization

During polymerization

< Configuration >

- Standard PMA-12 configuration (C14880, C14631, C10027, etc.)

Options

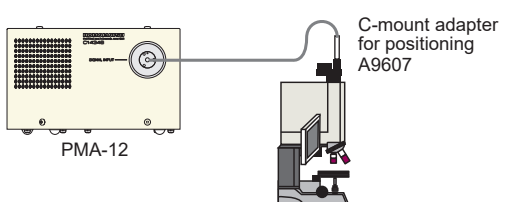
- Xe light source high stability 150 W L6759
- Sample Holder for transmission and fluorescence measurement A6751

< Applications >

- Absorption spectrum evaluations for solutions and films
- Component analysis for samples
- Monitoring chemical changes

Microscopic spectral measurements

Spectral distribution measurements under a microscope



PMA-12

C-mount adapter for positioning A9607

< Configuration >

- Standard PMA-12 configuration (C14880, C14631, C10027, etc.)

Option

- C-mount adapter for positioning A9607

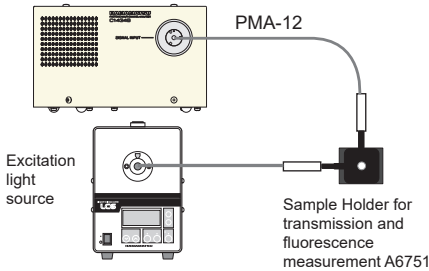
< Applications >

- Measurement of bioluminescence
- Measurements on semiconductor wafer, LCD and other microstructures

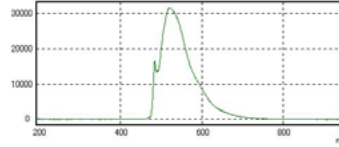
APPLICATION EXAMPLES

Emission spectrum measurements

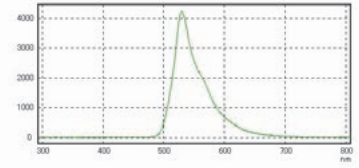
For fluorescent samples such as fluorescent lamps and EL devices



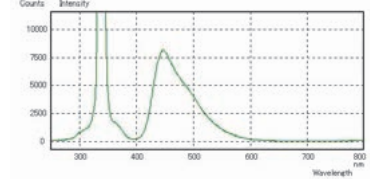
Fluorescence indicator (Fluorescein) emission spectrum



Chemiluminescence emission spectrum



Emission spectrum of fluorescent materials (Fluorescent lamp)



< Configuration >

- Standard PMA-12 configuration (C14880, C14631, C10027, etc.)

Options

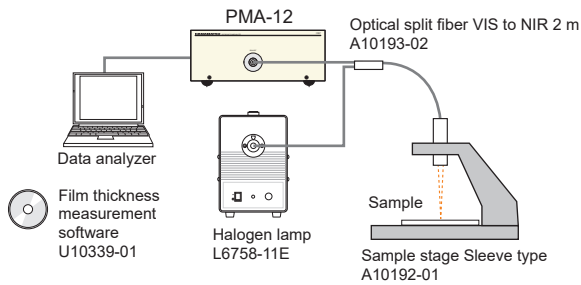
- Excitation light source: laser, xenon lamp, etc.
- Sample Holder for transmission and fluorescence measurement A6751

< Applications >

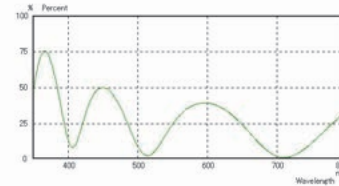
- Fluorescence spectroscopy
- Monitoring chemical light emissions

Film thickness measurements

Film thickness measurements using spectral reflectance or transmittance



ITO film interference spectrum



< Configuration >

- Standard PMA-12 configuration (C10027)

Options

- Halogen lamp L6758-11E
- Optical split fiber VIS to NIR 2 m A10193-02
- Film thickness measurement software U10339-01

< Applications >

- Monitoring thin film growth
- Film thickness management
- Resist film thickness measurements

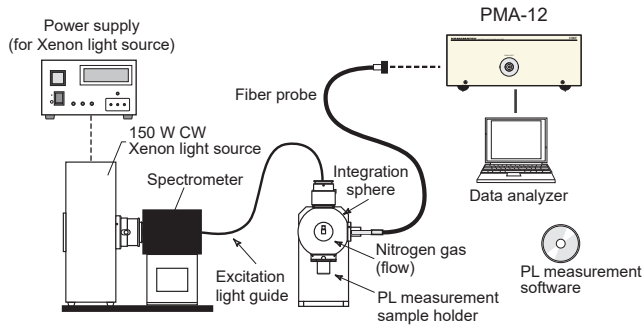
Optical Gauge series

C10178, C10323

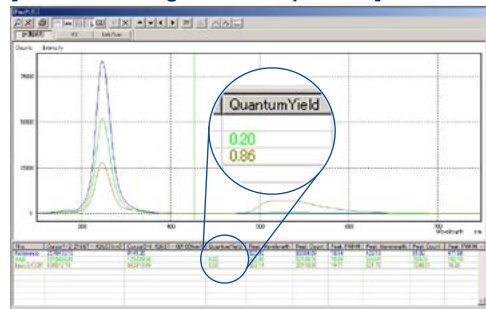
We can offer a special machine for film thickness measurements. Please refer to the details in a specific brochure.

Quantum yield measurement system

Measurement of quantum yield, external quantum efficiency, brightness light distribution characteristics



[Screen showing emission spectrum]



< Configuration >

- Standard PMA-12 configuration (C10027)

< Applications >

- Research of fluorescence materials in physics or chemistry
- Quantum yield measurement of emission materials
- Internal quantum yield measurement of fluorescence materials

Absolute PL quantum yield spectrometer C9920-02,-02G,-03,-03G

External quantum efficiency measurement system C9920-12

Light distribution measurement system C9920-11

We can offer a special machine for quantum yield measurements. Please refer to the details in a specific brochure.

OPTIONS



Sample Holder for transmission and fluorescence measurement A6751

This is a dedicated holder with an integrated condensing lens for the use with vials.



Reflection measurement optics A9665

These are optics making it possible to illuminate the sample at 45° to the light source and measure the reflected light.



Optical split fiber 2 m A10193-01,-02

It is very useful for reflectance measurement or film thickness measurement. We have two kinds of fiber. One is A10193-01 for from UV to visible light and the other is A10193-02 for from visible to NIR light range.



C-mount fiber adapter A6399

This is an adapter for securing the fiber input optics to the C-mount of a microscope or the like. The A6399 is usable in the UV to NIR.



C-mount adapter for positioning A9607

In addition to the function of the C-mount fiber adapter, the measurement position can be checked. The A9607 is usable in the UV to NIR.



Attenuation fiber adapter A10474-01

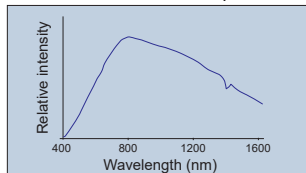
This adaptor is used when the light power is too strong. It can reduce the input light power by using a pinhole. (fading rate approx. 1/20 to 1/500)



Halogen lamp L6758-11E

This is a halogen light source with output wavelengths from 400 nm to 1600 nm for excitation and absorption measurements.

■ L6758-11E emission spectrum



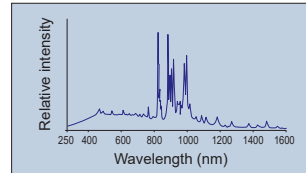
* Light guide connector A10194-01 is needed to connect with 2 split fiber.



Xe light source High stability 150 W L6759

This is a high stability xenon light source with output wavelengths from 250 nm to 1600 nm for excitation and absorption measurements.

■ L6759 emission spectrum



Software library U10472-01

This is the software library which controls the PMA-12 series.

Color measurement library U10473-01

This is the software library which controls the PMA-12 series and calculates the chromaticity.

SPECIFICATIONS

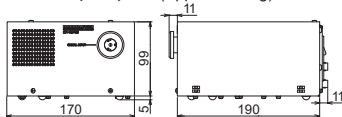
| Product number | C14631-01 | C14631-02 | C14631-03 | C14880-01 | C10027-01 | C10027-02 | C10028-01 | C10028-02 |
|--|--|------------------------------|-------------|------------------------|------------------------|-------------|-----------------------------|--|
| Photo-detector | BT-CCD linear image sensor | | | | | | InGaAs linear image sensor | |
| Wavelength (nm) | 300 to 800 | 250 to 840 | 300 to 1040 | 200 to 990 | 200 to 950 | 350 to 1100 | 900 to 1650 | 1600 to 2350 |
| Wavelength resolution (FWHM)*1 | ≤ 3 nm | ≤ 3 nm (Less than 750 nm) | ≤ 4 nm | < 2.5 nm | < 2 nm | < 2.5 nm | < 9 nm | |
| Wavelength accuracy | <±0.3 nm | | <±0.5 nm | <±0.3 nm | <±0.75 nm | | <±3.2 nm | |
| Exposure time (Internal trigger Mode) | 18 ms to 64 s | | | 19 ms to 64 s | | | 5 ms to 64 s | 5 ms to 0.05 s |
| Number of photosensitive device channels | 1024 ch | | | | | | 256 ch | |
| Pixel size | 24 μm × 1392 μm | | | 24 μm × 2928 μm | | | 50 μm × 250 μm | |
| Device cooling temperature | 0 °C | | | -10 °C | -15 °C | | | -10 °C |
| Read-out noise (electrons) (Max.) | 16 | | | | | | 18 750 | |
| Dark current (electrons/scan) (Max.) | 128 (0 °C : 20 ms) | | | 64 (-10 °C : 20 ms) | 32 (-15 °C : 20 ms) | | 163 000 (-10 °C : 20 ms) | 6.47 × 10 ⁸ (-10 °C : 20 ms) |
| AD resolution | 16 bit | | | | | | | |
| Spectrograph | Concave spherical grating type | | | Czerny-Turner type | | | | |
| Spectrograph F number | 3 | | | 4 | | | | |
| Fiber type | Bundled fiber Φ12 mm SUS tube | | | | | | | |
| Fiber length | 2 m | | | 1.5 m | | | | |
| Fiber receiving area | Φ1 mm | | | | | | | |
| External trigger input | TTL level/High impedance | | | | | | | |
| Interface | USB 2.0 ² | | | USB 3.0 ² | USB 2.0 ² | | | |
| Power supply | AC 100 V to AC 240 V, 50 Hz/60 Hz (Power supply voltage variation ±10 %) | | | | | | | |
| Power consumption | Approx. 40 VA | | | Approx. 50 VA | Approx. 70 VA | | Approx. 50 VA | |
| Ambient operating temperature | +10 °C to +35 °C | | | +10 °C to +30 °C | | | | |

*1 Confirmed with mercury and argon atomic beams. *2 1.5 m cable is included as standard.

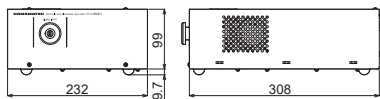
Dimensional outlines (Unit : mm)

Main unit

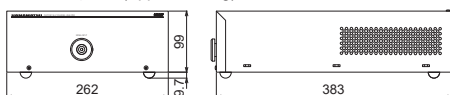
C14631-01, -02, -03 (Approx. 2.6 kg)



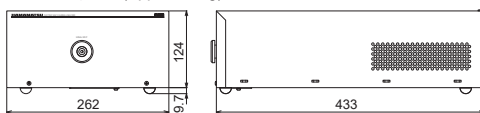
C14880-01 (Approx. 5.4 kg)



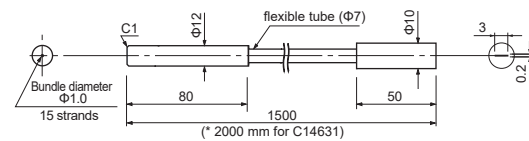
C10027-01, -02 (Approx. 5.7 kg)



C10028-01, -02 (Approx. 9 kg)



Fiber input optics (Approx. 100 g)



Basic software for PMA-12 U6039-01

- Measurement functions Monitoring measurement
Data measurement
- Temporal resolution measurement functions ... Temporal fluctuation of spectra
Temporal fluctuation in reflectivity and transmissivity
- Data acquisition condition settings Exposure time settings
Memory integration count assignment
- Calibration/correction Wavelength axis calibration
Sensitivity inconsistency calibration
Dark current correction
- Display functions Spectrum display
Display temporal waveform fluctuations
- Wavelength axis display Wavelength, Wavenumber, Raman shift, energy (eV)
- Brightness axis display Linear, Logarithmic
- Cursor functions Wavelength (wavenumber, etc.) vs. intensity
Peak detection
FWHM measurement
Integrated intensity
- Other functions Smoothing
Differential waveform
Color calculation (XYZ, xy, uv, Lab)

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